


<b>Search Notes</b>  	<b>Application/Control No.</b>  10522648	<b>Applicant(s)/Patent Under Reexamination</b>  SEKIYA, HIROSHI
	<b>Examiner</b>  Dinh Q Nguyen	<b>Art Unit</b>  3752

SEARCHED			
Class	Subclass	Date	Examiner
239	290,292,295,77,296	3/31/08	DN
101	147,148,424.1	3/31/08	DN
	updated search	10/26/08	DN

SEARCH NOTES		
Search Notes	Date	Examiner
East search attached	3/31/08	DN

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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